

UNITED STATES PATENT AND TRADEMARK OFFICE  
**CERTIFICATE OF CORRECTION**

PATENT NO. : 6,850,244 B2  
DATED : February 1, 2005  
INVENTOR(S) : Aaftab Munshi and Colin Sharp

Page 1 of 1

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Title page,

Item [73], Assignee, reads "**Micron Technology, Inc.,**" should read -- **Micron Technology, Inc.,** --.

Column 2,

Line 42, reads "values that may be unequal that are used" should read -- values that are used --.

Column 4,

Line 7, reads "detailed below," should read -- detail below, --.

Column 6,


Line 32, reads " $D = (f_u * P_u * scale_u) + (f_v * P_v * scale_v)$ ," should read

--  $D = (f_u * P_u * scale_u) + (f_v * P_v * scale_v)$ , --.

Line 41, reads "values  $scale_u$  and  $scale_v$ " should read -- values  $scale_u$  and  $scale_v$  --.

Signed and Sealed this

Sixteenth Day of August, 2005



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JON W. DUDAS

*Director of the United States Patent and Trademark Office*